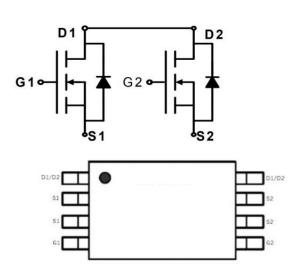


## 20 V N+N-Channel Enhancement Mode MOSFET

#### **Description**

The SX8205A-21 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.



#### **General Features**

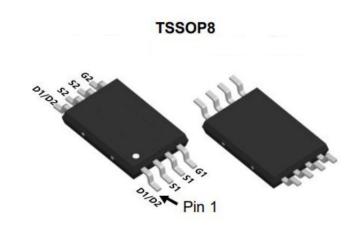
 $V_{DS}$ =20V  $I_D$  =6.5A

 $R_{DS(ON)} < 25m\Omega$  @  $V_{GS} = 10V$ 

#### **Application**

Lithium battery protection

Mobile phone fast charging



# Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	20	V
VGS	Gate-Source Voltage	±12	V
<b>ID@TA=25℃</b>	Continuous Drain Current1	6.5	A
<b>ID@TA=70</b> ℃	Continuous Drain Current1	4.8	А
IDM	Pulsed Drain Current2	24	Α
PD@TA=25℃	Total Power Dissipation3	1.5	W
TSTG	Storage Temperature Range	-55 to 150	$^{\circ}$ C
TJ	TJ Operating Junction Temperature -55 to 150 Range		$^{\circ}$
Reja	Thermal Resistance Junction-ambient <sup>1</sup>	85	°C/W





## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Cumbal	Dovometer	Conditions	Min	Tim	Mov	l lmi4
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	20	22		V
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =5A		19	25	0
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =2.5V , I <sub>D</sub> =4A		24	40	mΩ
VGS(th)	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250uA$	0.5	0.7	1.2	V
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> = 16V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
IGSS	Gate-Source Leakage Current	Vgs=±8V , Vps=0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =3.5A		20		s
Qg	Total Gate Charge (4.5V)			11.4		
Qgs	Gate-Source Charge	V <sub>DS</sub> =15V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =7A		1.6		nC
Qgd	Gate-Drain Charge			2.9		
Td(on)	Turn-On Delay Time			5		
$T_r$	Rise Time	V <sub>DD</sub> =10V , V <sub>GS</sub> =4.5V ,		32.4		
Td(off)	Turn-Off Delay Time	R <sub>G</sub> =3.3 I <sub>D</sub> =5A		28		ns
Tf	Fall Time			9		
Ciss	Input Capacitance			863		
Coss	Output Capacitance	V <sub>DS</sub> = 15V , V <sub>GS</sub> =0V , f=1MHz		87		pF
Crss	Reverse Transfer Capacitance			71		
<b>l</b> s	Continuous Source Current <sup>1,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			6	Α
Vsp	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	V

#### Note

- $1\,{}_{\backsim}$  The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2 . The data tested by pulsed , pulse width  $\,\, \leqq \, 300 \text{us}$  , duty cycle  $\,\, \leqq \, 2\%$
- 4 . The power dissipation is limited by  $175\,^\circ\!\text{C}\textsc{junction}$  temperature
- $5\sqrt{1}$  The data is theoretically the same as 1D and 1DM, in real applications, should be limited by total power dissipation.

2



## **Typical Characteristics**

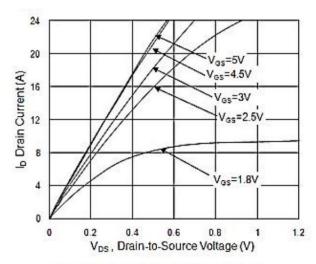


Fig.1 Typical Output Characteristics

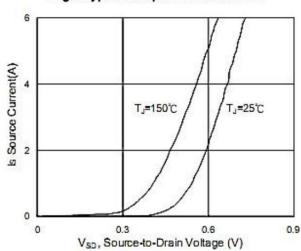


Fig.3 Forward Characteristics of Reverse

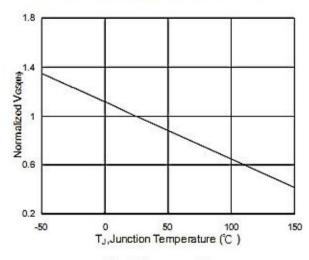


Fig.5 V<sub>GS(th)</sub> vs. T<sub>J</sub>

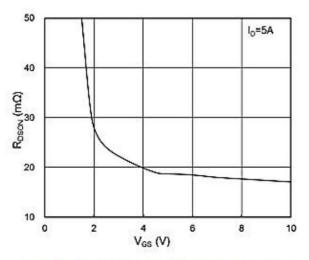


Fig.2 On-Resistance vs. Gate-Source Voltage

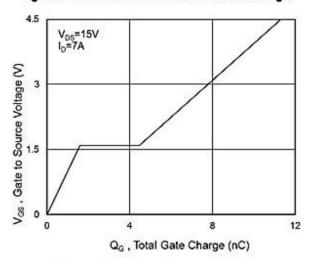


Fig.4 Gate-Charge Characteristics

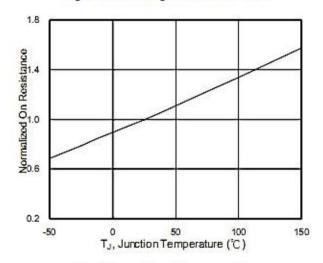
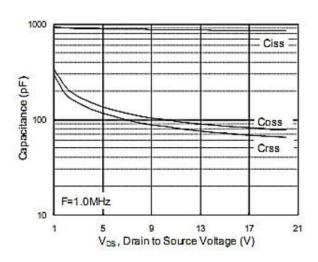


Fig.6 Normalized RDSON vs. TJ



#### **Typical Characteristics**



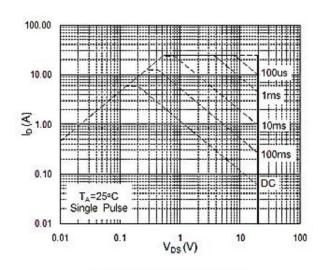


Fig.7 Capacitance

Fig.8 Safe Operating Area

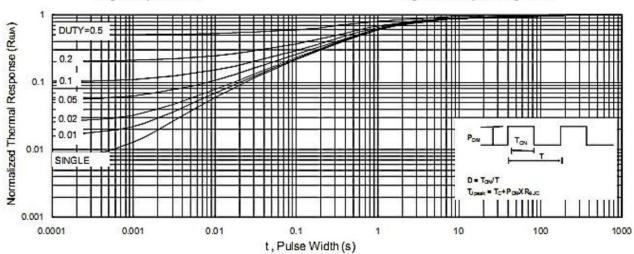


Fig.9 Normalized Maximum Transient Thermal Impedance

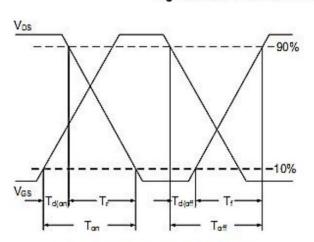


Fig.10 Switching Time Waveform

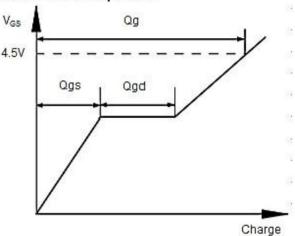
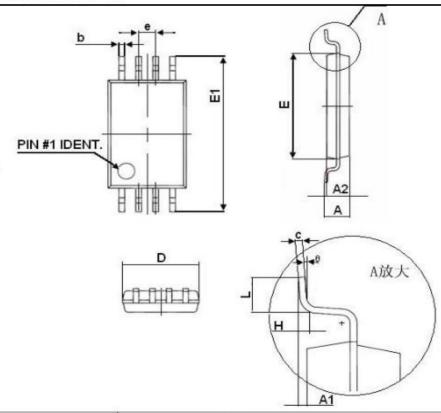


Fig.11 Gate Charge Waveform



# Package Mechanical Data



Same al	Dimensions	In Millimeters
Symbol	Min	Max
D	2.900	3.100
E	4.300	4.500
b	0.190	0.300
С	0.090	0.200
E1	6.250	6.550
Α		1.100
A2	0.800	1.000
A1	0.020	0.150
е	0.65(	BSC)
L	0.500	0.700
н	0.25	(TYP)
Θ	1°	7°

**Package Marking and Ordering Information** 

Product ID	Pack	Marking	Qty(PCS)
TAPING	TSSOP-8		5000

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